Notice of References Cited Application/Control No. 10/635,783 Examiner Sonny TRINH Applicant(s)/Patent Under Reexamination AN ET AL. Art Unit Page 1 of 1

U.S. PATENT DOCUMENTS

	,,			· · · · · · · · · · · · · · · · · · ·	
*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	Α	US-2004/0266445	12-2004	Burgess et al.	455/450
*	В	US-2003/0174674	09-2003	Lee et al.	370/331
*	C	US-2003/0161283	08-2003	Tiedemann et al.	370/329
*	ם	US-6,952,583	10-2005	Park et al.	455/434
*	E	US-2002/0141371	10-2002	Hsu, Raymond T.	370/338
*	F	US-2006/0246885	11-2006	Lee, Jonghun	455/421
*	G	US-6,381,235	04-2002	Kamel et al.	370/342
*	Ι	US-5,768,267	06-1998	Raith et al.	370/329
	_	US-			
	7	US-			
	K	US-			
	L	US-			
	М	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	0					
	Р					
	Q					
	R					
	S					
	Т					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	w	
	x	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).) Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.